

APPLICATION DATA SHEET	
<b>Title:</b>	METHOD OF DETERMINING CLINICAL SEVERITY OF FALSE
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<b>PCT and Foreign Priority:</b>	This Application is the National Phase of International Application No. PCT/JP2004/018410 filed December 9, 2004, which designated the U.S. and was not published under PCT Article 21(2) in English, and this application claims, via the aforesaid International Application, the foreign priority benefit of and claims the priority from Japanese Application No. 2003-413629, filed December 11, 2003, the complete disclosures of all the aforesaid applications, including any and all sequence listings, are incorporated herein by reference.